

# UNISONIC TECHNOLOGIES CO., LTD

### 1D5N10

Preliminary

## 1.5A, 100V N-CHANNEL LOGIC LEVEL ENHANCEMENT MODE FIELD EFFECT TRANSISTOR

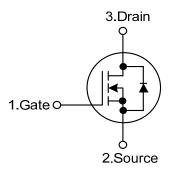
#### DESCRIPTION

The UTC **1D5N10** is a N-channel MOSFET, it uses UTC's advanced technology to provide the customers with high switch speed and low gate charge.

#### FEATURES

- \*  $R_{DS(ON)} \le 0.6 \ \Omega \ @ V_{GS}=10V, I_D=0.75A$
- \* High switch speed
- \* Low gate charge

#### SYMBOL



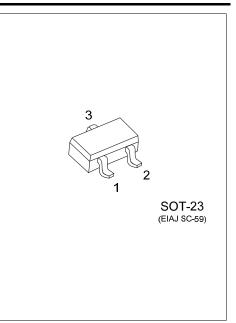
#### ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Decking	
Lead Free	Lead Free Halogen Free		1	2	3	Packing	
1D5N10L-AE3-R	5N10L-AE3-R 1D5N10G-AE3-R		G	S	D	Tape Reel	
Note: Pin Assignment: G: Gate S: Source D: Drain							

1D	5N10G-AE3-R T T (1)Packing Type	(1) R: Tape Reel
	(2)Package Type	(2) AE3: SOT-23
	(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

#### MARKING





#### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V <sub>DSS</sub>	100	V	
Gate-Source Voltage		V <sub>GSS</sub>	±20		
Drain Current	Continuous T <sub>A</sub> =25°C		1.5	А	
	(Note 1) T <sub>A</sub> =70°C	I <sub>D</sub>	1.2	А	
	Pulsed (Note 2)	I <sub>DM</sub>	6	А	
	T <sub>A</sub> =25°C	Б	1.25	W	
Power Dissipation (Note T)	wer Dissipation (Note 1) $\begin{array}{c c} T_A = 25 \text{ C} \\ T_A = 70^{\circ} \text{C} \end{array}$ P <sub>D</sub> $\begin{array}{c c} 1.25 \\ 0.8 \end{array}$	W			
Junction Temperature		TJ	-55 ~ +150	°C	
torage Temperature Range		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

#### ■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT		
Junction to Ambient	θ <sub>JA</sub>	100	°C/W		

Note: The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

#### ELECTRICAL CHARACTERISTICS (T<sub>A</sub>=25°C, unless otherwise specified)

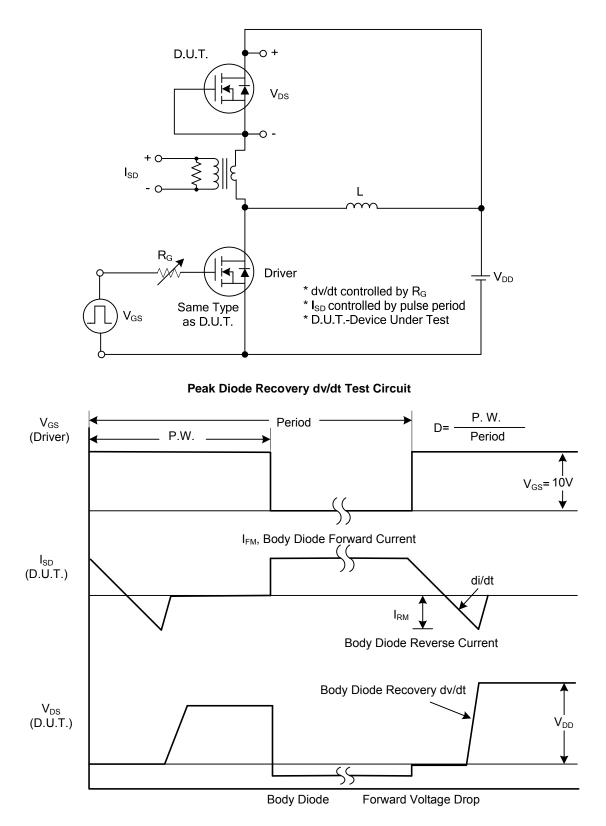
		0					
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltag	ain-Source Breakdown Voltage		I <sub>D</sub> =250μΑ, V <sub>GS</sub> =0V	100			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V			1	μA
Gate-Source Leakage Current	Forward	699	V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V			+100	nA
	Reverse		V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	0.8		1.2	V
Static Drain-Source On-State Re	esistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =0.75A			0.6	Ω
DYNAMIC PARAMETERS (Note	e 3)						
Input Capacitance		C <sub>ISS</sub>			170		рF
Output Capacitance		Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		34		рF
Reverse Transfer Capacitance	everse Transfer Capacitance				8.2		рF
SWITCHING PARAMETERS (N	ote 3)						
Total Gate Charge		$Q_{G}$			10		nC
Gate to Source Charge		$Q_{GS}$	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =1.3A 0.7			nC	
Gate to Drain Charge		$Q_{GD}$	-l <sub>G</sub> -100μΑ	0MHz 34 8.2 1.3A 10		nC	
Turn-ON Delay Time		t <sub>D(ON)</sub>			8		ns
Rise Time	· · · · · · · · · · · · · · · · · · ·		V <sub>DD</sub> =30V, I <sub>D</sub> =0.5A,		14		ns
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	$R_{GEN}$ =25 $\Omega$ , $V_{GS}$ =10V		86		ns
Fall-Time		t⊨			60		ns
SOURCE- DRAIN DIODE RATI	NGS AND (	CHARACTER	ISTICS				
Continuous Drain-Source Currer	nt	ls				1.5	Α
Pulsed Drain-Source Current		I <sub>SM</sub>				6.0	Α
Drain-Source Diode Forward Vo	Itage	$V_{SD}$	I <sub>S</sub> =1.5A, V <sub>GS</sub> =0V		0.8	1.2	V

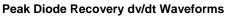
Note: 1. Pulse Test : Pulse width  $\leq$  300µs, Duty cycle $\leq$  2%.

2. Essentially independent of operating temperature.



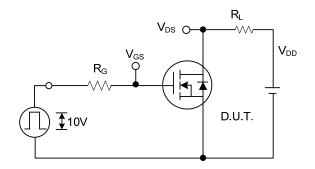
#### TEST CIRCUITS AND WAVEFORMS



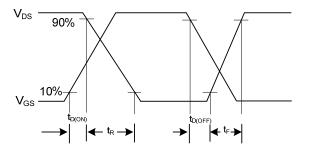




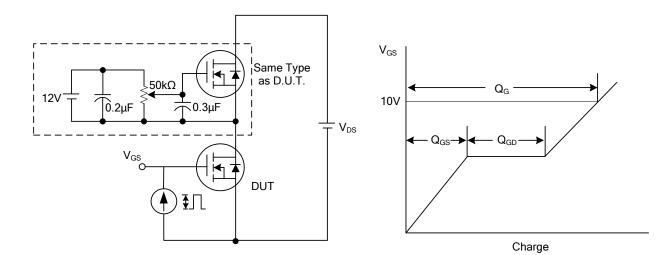
#### ■ TEST CIRCUITS AND WAVEFORMS (Cont.)





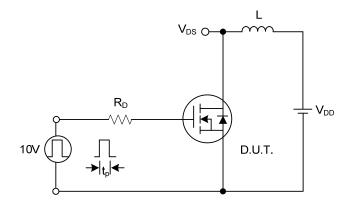


Switching Waveforms

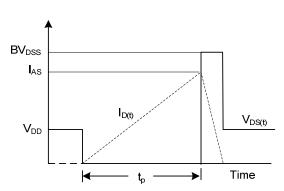


**Gate Charge Test Circuit** 

Gate Charge Waveform



**Unclamped Inductive Switching Test Circuit** 



#### **Unclamped Inductive Switching Waveforms**



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